## Substitute for form 1449APTO & 1449BPPTO FIRST INFORMATION DISCLOSUE

## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Complete if Known				
Application Number	10/721,232			
Filing Date	November 26, 2003			
First Named Inventor	Rolf FREIMANN, et al.			
Examiner Name	Unassigned			
Attorney Docket Number	007413-068			

(use as many sheets as necessary)

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Examiner	Document Number	Kind Code (if known)	Name of Patentee or Applicant of Cited Document	Issue/Publication Date (MM-DD-YYYY)
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Initials	Number	(if known) Country Date of Public (MM-DD-Y	(MM-DD-YYYY)	Yes	No	
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NON-PATENT LITERATURE DOCUMENTS				
Examiner Initials	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			
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Signature	- · / / / / / / C	I Considered I	, , , , , , , , , , , , , , , , , , , ,

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with M.P.E.P. § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.